Thermally-Enhanced High Power RF GaN on SiC HEMT 1400 W, 50 V, DC – 1400 MHz

Description

The GTVA101K42EV is a 1400-watt GaN on SiC high electron mobility transistor (HEMT) for use in the DC to 1400 MHz frequency band. It is a input matched, high efficiency device in a thermally-enhanced package with bolt-down flange.



GTVA101K42EV Package H-36275-4

Features

- GaN on SiC HEMT technology
- · Input matched
- Typical Pulsed CW performance, 960 1400 MHz, 50
 V, single side, 128 µs pulse width, 10% duty cycle
 - Output power at P_{3dB} = 1400 W
 - Efficiency = 68%
 - Gain = 17 dB
- · Pb-free and RoHS compliant

RF Characteristics¹

Pulsed CW Specifications (tested in Wolfspeed test fixture)

 $V_{DD} = 50 \text{ V}, I_{DO} = 75 \text{ mA}, P_{OUT} (P3dB) = 1400 \text{ W peak}, f = 1030 \text{ MHz}, Pulse Width = 128 \mu s, Duty Cycle = 10\% Pulse Width = 128 \mu s, Duty Cycle$

| Characteristic | Symbol | Min | Тур | Max | Unit |
|-------------------------------------|------------|-----|-----|------|------|
| Linear Gain | G_ps | 17 | 19 | _ | dB |
| Return Loss | R | _ | -19 | -12 | dB |
| Drain Efficiency | η_{D} | 65 | 69 | _ | % |
| Output Mismatch Stress ² | VSWR | _ | _ | 10:1 | Ψ |

Note ¹: All published data at T_{CASE} = 25°C unless otherwise indicated.

Note 2 : No damage at all phase angles, $V_{DD} = 50 \text{ V}$, $I_{DQ} = 75 \text{mA}$, $P_{OUT} = 1400 \text{ W}$ Pulsed.

Note ³: ESD: Electrostatic discharge sensitive device—observe handling precautions!

DC Characteristics

| Characteristic | Conditions | Symbol | Min | Тур | Max | Unit |
|--------------------------------|--|----------------------|------|------|------|------|
| Drain-source Breakdown Voltage | $V_{GS} = -8 \text{ V}, I_D = 83.6 \text{ mA}$ | V _{(BR)DSS} | 125 | | | V |
| Drain-source Leakage Current | $V_{GS} = -6 \text{ V}, V_{DS} = 2 \text{ V}$ | I _{DSS} | 62.7 | 75.5 | _ | Α |
| Gate Threshold Voltage | $V_{DS} = 10 \text{ V}, I_D = 83.6 \text{ mA}$ | $V_{GS(th)}$ | -3.8 | -3.0 | -2.7 | V |

Recommended Operating Conditions

| Parameter | Conditions | Symbol | Min | Тур | Max | Unit |
|-------------------------|---|-------------|-----|------|-----|------|
| Drain Operating Voltage | | V_{DD} | 0 | _ | 50 | V |
| Gate Quiescent Voltage | $V_{DS} = 50 \text{ V}, I_D = 100 \text{ mA}$ | $V_{GS(Q)}$ | _ | -3.1 | _ | V |

Absolute Maximum Ratings

| Parameter | Symbol | Value | Unit |
|---------------------------|------------------|-------------|------|
| Drain-source Voltage | V_{DSS} | 150 | V |
| Gate-source Voltage | V_{GS} | -10 to +2 | V |
| Gate Current | I _G | 167 | mA |
| Drain Current | I _D | 48 | А |
| Junction Temperature | Tj | 225 | °C |
| Storage Temperature Range | T _{STG} | -65 to +150 | °C |

Operation above the maximum values listed here may cause permanent damage. Maximum ratings are absolute ratings; exceeding only one of these values may cause irreversible damage to the component. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. For reliable continuous operation, the device should be operated within the operating voltage range (V_{DD}) specified above.

Thermal Characteristics

| Parameter | Symbol | Value | Units | |
|---|----------------|-------|-------|--|
| Thermal Resistance, Junction to case ¹ | $R_{	heta JC}$ | .127 | °C/W | |
| Thermal Resistance, Junction to case ² | $R_{	heta JC}$ | .167 | °C/W | |
| Thermal Resistance, Junction to case ³ | $R_{	heta JC}$ | .166 | °C/W | |

 $^{^{1}}$ Tcase = 85°C, P_{DISS} = 700 W, 100 μ s Pulse Width, 10% Duty Cycle

Electrical Characteristics When Tested in GTVA101K42EV-AMP2

| Characteristics | Symbol | Min. | Тур. | Max. | Units | Conditions |
|---|--------|------|------|------|-------|--|
| RF Characteristics ¹ (T _C = 25 °C, F ₀ = 1.2 - 1.4 GHz unless otherwise noted) | | | | | | |
| Output Power ² | Pout | _ | 61 | _ | dBm | $V_{DD} = 50 \text{ V}, I_{DQ} = 1.8 \text{ A}, P_{IN} = 44 \text{ dBm}$ |
| Power Added Efficiency ² | η | - | 55 | _ | % | $V_{DD} = 50 \text{ V}, I_{DQ} = 1.8 \text{ A}, P_{IN} = 44 \text{ dBm}$ |
| Gain ² | G | - | 17 | _ | dB | $V_{DD} = 50 \text{ V}, I_{DQ} = 1.8 \text{ A}, P_{IN} = 44 \text{ dBm}$ |

 $^{^{1}}$ Measured in the GTVA101K42EV-AMP2 Application Circuit

² Tcase = 85°C, P_{DISS} = 700 W, 500 µs Pulse Width, 10% Duty Cycle

³ Tcase = 85°C, P_{DISS} = 700 W, Mode-S Signal

² Pulsed 500 μs, 10% Duty Cycle

Test conditions unless otherwise noted: V_D = 50 V, I_{DO} = 1800 mA, Pulse Width = 500 μs, Duty Cycle = 10%, Pin = 44 dBm, T_{BASE} = +25 °C

Figure 1. Output Power vs Frequency as a Function of Temperature

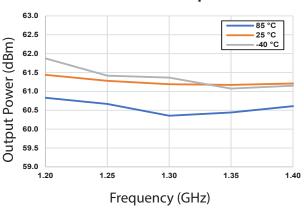


Figure 2. Output Power vs Frequency as a Function of Input Power

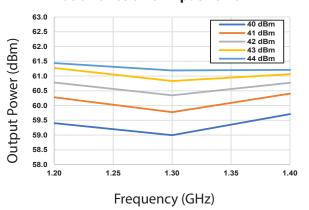


Figure 3. Power Added Eff. vs Frequency as a Function of Temperature

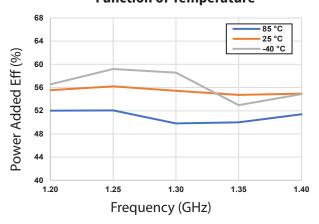


Figure 4. Power Added Eff. vs Frequency as a Function of Input Power

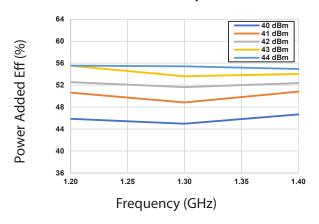


Figure 5. Drain Current vs Frequency as a Function of Temperature

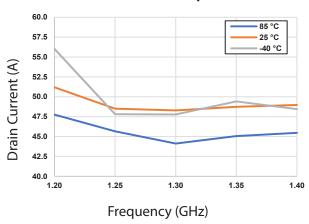
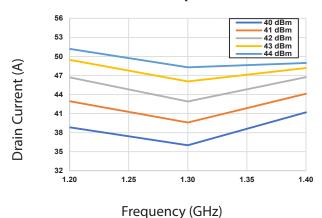


Figure 6. Drain Current vs Frequency as a Function of Input Power



Test conditions unless otherwise noted: V_D = 50 V, I_{DO} = 1800 mA, Pulse Width = 500 μs, Duty Cycle = 10%, Pin = 44 dBm, T_{BASE} = +25 °C

Figure 7. Output Power vs Frequency as a Function of VD

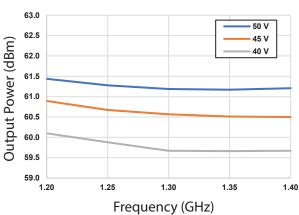


Figure 8. Output Power vs Frequency as a Function of IDQ

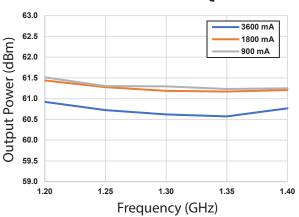


Figure 9. Power Added Eff. vs Frequency as a **Function of VD**

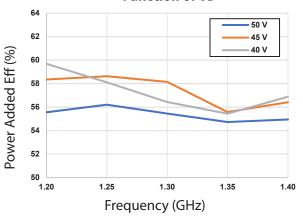


Figure 10. Power Added Eff. vs Frequency as a Function of IDQ

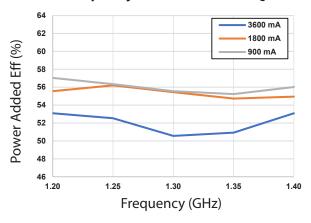


Figure 11. Drain Current vs Frequency as a Function of VD

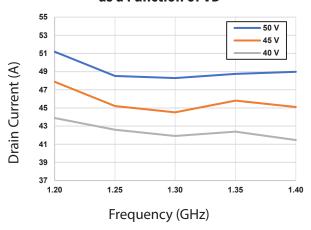
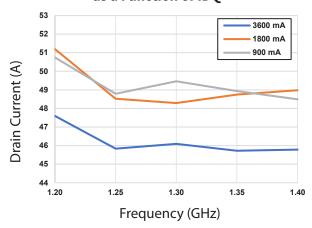


Figure 12. Drain Current vs Frequency as a Function of IDQ



Test conditions unless otherwise noted: $V_D = 50 \text{ V}$, $I_{DQ} = 1800 \text{ mA}$, Pulse Width = $500 \mu s$, Duty Cycle = 10%, Pin = 44 dBm, $T_{BASE} = +25 ^{\circ}\text{C}$

Figure 13. Output Power vs Input Power as a Function of Frequency

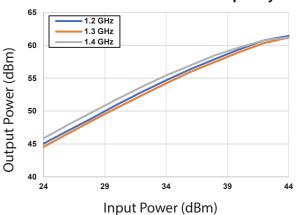


Figure 15. Large Signal Gain vs Input

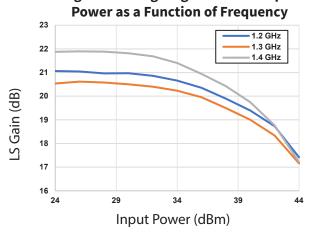


Figure 17. Gate Current vs Input Power as a Function of Frequency

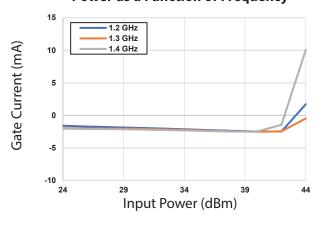


Figure 14. Power Added Eff. vs Input Power as a Function of Frequency

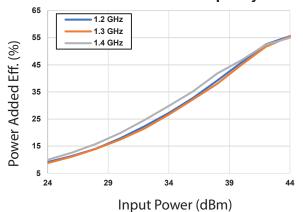


Figure 16. Drain Current vs Input Power as a Function of Frequency

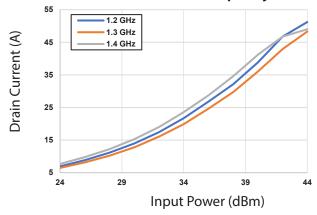
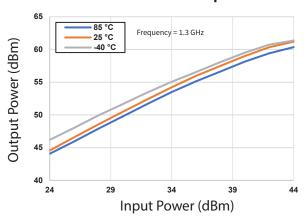


Figure 18. Output Power vs Input Power as a Function of Temperature



Power Added Eff. (%)

Typical Performance of the GTVA101K42EV-AMP2

Test conditions unless otherwise noted: $V_D = 50 \text{ V}$, $I_{DQ} = 1800 \text{ mA}$, Pulse Width = 500 μ s, Duty Cycle = 10%, Pin = 44 dBm, $T_{BASE} = +25 \,^{\circ}\text{C}$

Figure 19. Power Added Eff. vs Input Power as a Function of Temperature

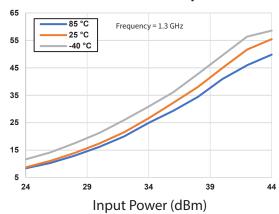


Figure 21. Drain Current vs Input Power as a Function of Temperature

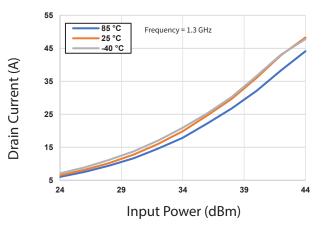


Figure 23. Output Power vs Input
Power as a Function of IDQ

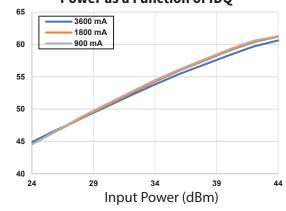


Figure 20. Large Signal Gain vs Input Power as a Function of Temperature

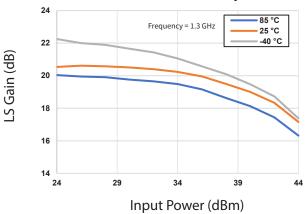


Figure 22. Gate Current vs Input Power as a Function of Temperature

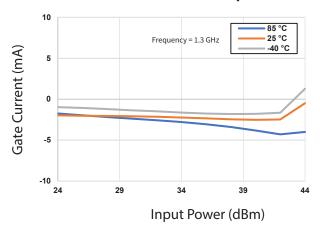
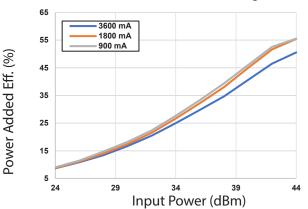


Figure 24. Power Added Eff. vs Input Power as a Function of IDQ



Output Power (dBm)

Test conditions unless otherwise noted: V_D = 50 V, I_{DO} = 1800 mA, Pulse Width = 500 μs, Duty Cycle = 10%, Pin = 44 dBm, T_{BASE} = +25 °C

Figure 25. 2nd Harmonic vs Frequency as a Function of Temperature

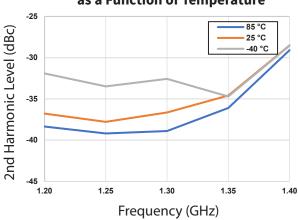


Figure 26. 3rd Harmonic vs Frequency as a Function of Temperature

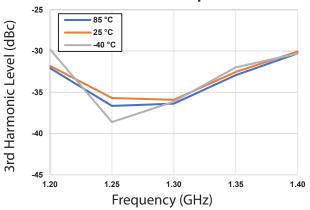


Figure 27. 2nd Harmonic vs Output **Power as a Function of Frequency**

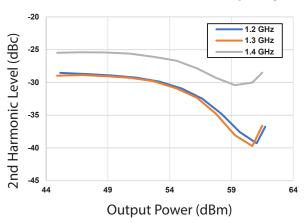


Figure 28. 3rd Harmonic vs Output **Power as a Function of Frequency**

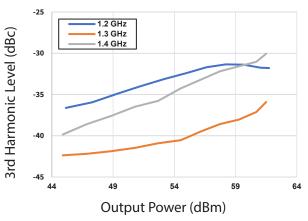


Figure 29. 2nd Harmonic vs Output Power as a Function of IDQ

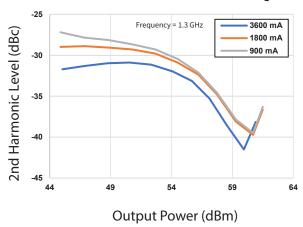
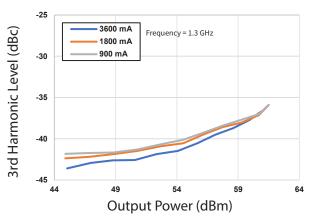


Figure 30. 3rd Harmonic vs Output Power as a Function of IDQ



Test conditions unless otherwise noted: $V_D = 50 \text{ V}$, $I_{DQ} = 1800 \text{ mA}$, Pin = -20 dBm, $T_{BASE} = +25 ^{\circ}\text{C}$

Figure 31. Gain vs Frequency as a Function of Temperature

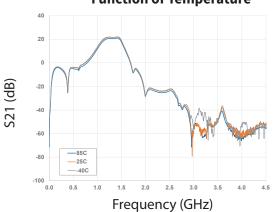


Figure 33. Input RL vs Frequency as a Function of Temperature

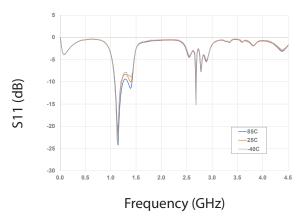


Figure 35. Output RL vs Frequency as a Function of Temperature

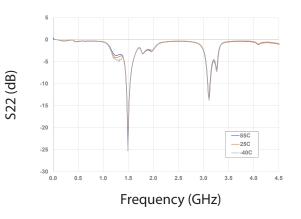


Figure 32. Gain vs Frequency as a Function of Temperature

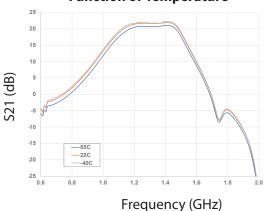


Figure 34. Input RL vs Frequency as a Function of Temperature

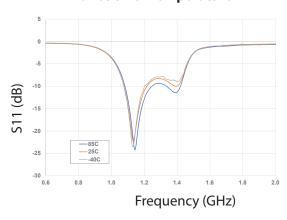
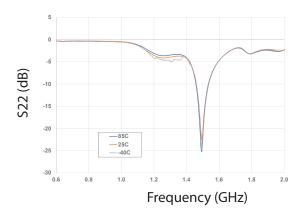


Figure 36. Output RL vs Frequency as a Function of Temperature



Test conditions unless otherwise noted: V_D = 50 V, I_{DO} = 1800 mA, Pin = -20 dBm, T_{BASE} = +25 °C

Figure 37. Gain vs Frequency as a Function of Voltage

Figure 39. Input RL vs Frequency as a Function Voltage

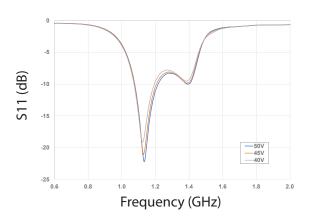


Figure 41. Output RL vs Frequency as a Function of Voltage

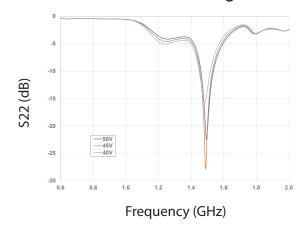


Figure 38. Gain vs Frequency as a Function of IDQ

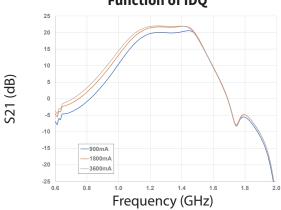


Figure 40. Input RL vs Frequency as a Function of IDQ

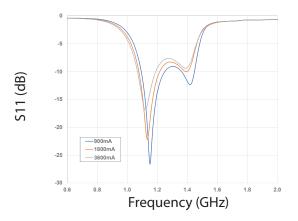
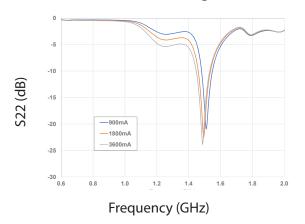
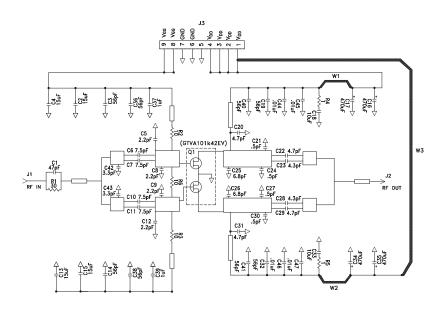


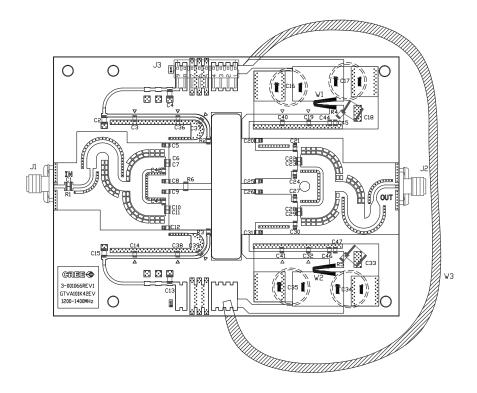
Figure 42. Output RL vs Frequency as a Function of Voltage



GTVA101K42EV-AMP2 Application Circuit Schematic



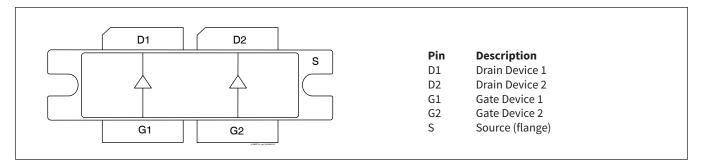
GTVA101K42EV-AMP2 Application Circuit



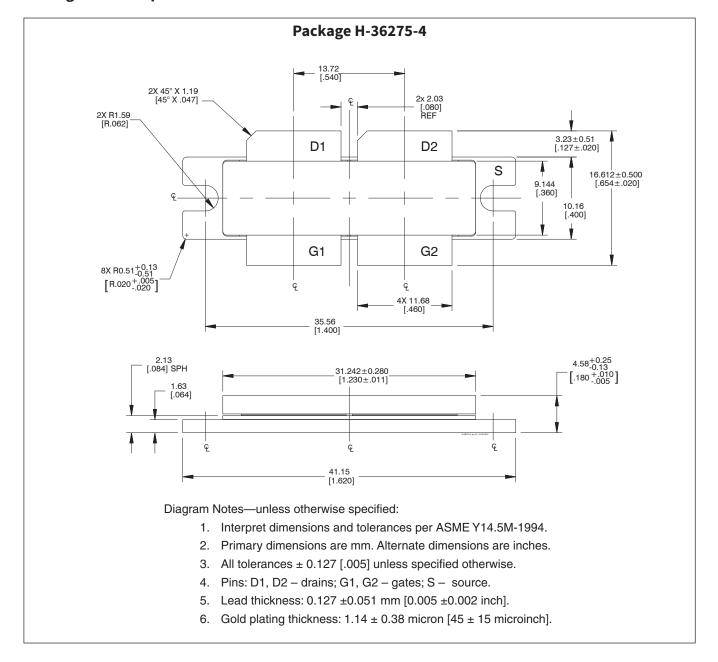
GTVA101K42EV-AMP2 Application Circuit Bill of Materials

| Designator | Description | Qty |
|---------------------------------------|---|-----|
| R1 | RES, 30 OHMs, +/- 1%, 0805, 1/8W, YAGEO | 1 |
| R2, R3 | RES, 10 OHMS, +/- 1%, 0805, 1/8W, YAGEO | 2 |
| R4, R5 | RES, 1 OHMS, +/- 5%, 1206, 125mW, AVX | 2 |
| R6 | RES, 10 OHMS, +/1%, 1206, 1/4W | 1 |
| C1 | CAP, 47pF, +/- 5%, 250V, 0805, ATC 600F | 1 |
| C2,C4, C13, C15 | CAP, 15uF, +/-20%, 10V, X7s, 1206, TDK | 4 |
| C3, C14, C19, C32, C36, C38, C40, C41 | CAP, 56pF, +/- 5%, 250V, 0805, ATC, 600F | 8 |
| C5, C8, C9, C12 | CAP, 2.2pF, +/1pF, 250V, 0805, ATC 600F | 4 |
| C6, C7, C10, C11 | CAP, 7.5pF, +/25pF, 250V, 0805, ATC 600F | 4 |
| C16, C17, C34, C35 | CAP, 470uF, +/-20%, 80V, Electrolytic, Vishay | 4 |
| C18, C33 | CAP, 10uF, +/- 10%, 100V, X7S, 2220, TDK | 2 |
| C20, C22, C29, C31 | CAP, 4.7pF, +/25pF, 250V, 0805, ATC 600F | 4 |
| C21, C24, C27, C30 | CAP, .5pF, +/05pF, 250V, 0805, ATC 600F | 4 |
| C23, C28 | CAP, 4.3pF, +/25pF, 250V, 0805, ATC 600F | 2 |
| C25, C26 | CAP, 6.8pF, +/25pF, 250V, 0805, ATC 600F | 2 |
| C37, C39 | CAP, 1uF, 100V, X7S, 0805, Murata | 2 |
| C44, C45, C46, C47 | CAP, .01uF, 50V, X7R | 4 |
| C42, C43 | CAP, 3.3pF, +/1pF, 250V, 0805, ATC 600F | 2 |
| W1, W2 | Wire, 3.25", 18AWG | 2 |
| W3 | Wire, 7", 12AWG | 1 |
| Q1 | Transistor, GTVA101K42EV | 1 |

Pinout Diagram (top view)



Package Outline Specifications



Product Ordering Information

| Order Number | Description | Unit of Measure | Image |
|---------------------|---|-----------------|-----------|
| GTVA101K42EV-V1-R0 | GaN HEMT, Tape & Reel, 50 pcs | Each | H-36275-4 |
| GTVA101K42EV-V1-R2 | GaN HEMT, Tape & Reel, 250 pcs | Each | H-36275-4 |
| LTN/GTVA101K42EV V1 | Test Board with GaN HEMT installed IFF, 1030 MHz | Each | |
| GTVA101K42EV-AMP2 | Test board with GaN HEMT installed L-Band Radar, 1.2 - 1.4 GHz | Each | |

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Notes

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